Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/539,804	INOUE ET AL.		
Examiner	Art Unit		
Jay M. Patidar	2862		

SEARCHED						
	SEARCHED					
Class	Subclass	Date	Examiner			
324	207.25	10/2/2006	JP			
	173-174					
384	448					

INI	INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner				
			j				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
EAST searched. TEXT searched.		10/2/2006	JP	